

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

IECQ Certificate of Approval Independent Testing Laboratory

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Materials Service Platform Corporation Elemental Analysis Laboratory

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The organization, facilities and procedures have been assessed and found to comply with the applicable requirements for Independent Testing Laboratory organization approval, in support of the IECQ system, which is in accordance with the Basic Rules IECQ 01 and Rules of Procedure IECQ 03-6 "Independent Testing Laboratory Assessment Program Requirements" of the IEC Quality Assessment System for Electronic Components (IECQ) and applicable requirements of ISO/IEC 17025:2017 for the testing of electronic components under the IECQ.

Scope:

Material analysis and chemical analysis of semiconductor.

See attached Schedule.

-- Attached Schedule: IECQ-L_ULTW_50600585 ITL. Schedule 04-05-24.pdf --

Approved by Certification Body (CB): DQS Group - DQS Taiwan Inc.

8F, 23, Yuan Huan West Road, Feng Yuan Dist., Taichung City Taiwan

Authorized person:

Bob CHEN







The validity of this certificate is maintained through on-going surveillance audits by the IECQ CB issuing this certificate.

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